

Component Title: Microcircuits, Digital CMOS, 54HCMOS Series

Appl. No.

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19/03/2020 **CNFS** Executive Member: Date: 190N 1 Components (including series and families) submitted for Extension of Qualification Approval: **ESCC** COMPONENT BASED TEST COMPONENT **VARIANTS** RANGE OF COMPONENTS VEHICLE / S SIMILAR ON NO. As per QPL As per QPL **54HC00KT 54HC74DT** 54HC245KG 54HC165KG 2 3 4 Location of Manufacturing Plant(s) Component Manufacturer Date of original qualification approval: STMicroelectronics Rennes, FRANCE 01/11/1992 Date: Certificate Ref No. 190 7 5 6 ESCC Specifications used for Deviations to LVT testing and Detail Specification Qualification Extension Report Maintenance of qualification testing: used: reference and date: Generic: 9000 10 Issue: No (supply details in Box M54HC00KT - ID33126D17YY DC 1902A M54HC74DT - ID33740004ZJ DC1901A Detail(s): 9201/015 Issue: 5 Deviation from current Specifications: 9203/050 4 M54HC245KG - ID3382400401 DC 1906A (Supply details) M54HC165KG - ID3390600201 DC1908A 8 Summary of procurement or equivalent test results during current validity period in support of this application (those to ESCC listed first) LAT Testing Level **Quantity Delivered** Project Name Date code ESCC900 Issue Lots delivered from January 60 630 Various 2018 to December 2019 10 CNES PID changes since start of qualification 9 10 Current PID Verified by: Name of Excutive Representative Agency None Ref No: PID GENERIQUE Ref. 8097046 revision 23.0, 31/01/2020, Minor* X PID HCMOS Ref. 8237625 rev.9.0, 03/03/2020 23.0 (Gen) & 9.0 (HCMOS) 19/03/2020 П Issue: Date: Major* *Provide details in box: Rev Date: 03/03/2020 11 Current Manufacturing facilities surveyed by: **CNES** 27/03/2018 (Name of Executive Representative Agency) (Date) Satisfactory: No Explain \boxtimes Report Reference: CR-ST-27-03-18



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Failure Analysis, DPA, NCCS available:

Yes

No

(Supply data)

Ref. No's and purposes:

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The undersigned hereby certifies on behalf of the ESCC Executive - that the above information is correct; - that the appropriate documentation has been evaluated; - that full compliance to all ESCC requirements is evidence (except as stated in box 15;) - that the reports and data are available at the ESCC Executive and therefore applies on behalf of CNES as the responsible Executive Member for ESCC qualification status to be extended to the component(s) listed herein.

Date: 25/03/2020

JP. BUSSENOT

(Signature of the Executive Coordinator)

Continuation of Boxes above:

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[7] Qualification Extension reports:

The extension is based on collection of 54HCMOS and CMOS 4000B data :

AMK 5"

M54HC00KT – ID33126D17YY DC 1902A - ESCC 9000 chart F4 sg1-3 M54HC74DT – ID33740004ZJ DC1901A - ESCC 9000 chart F4 sg1-3

AMK 6":

M54HC245KG - ID3382400401 DC 1906A - ESCC 9000 chart F4 sg2 M54HC165KG- ID3390600201 DC1908A - ESCC 9000 chart F4 sg2

Package qualification:

Dual in Line: M54HC74DT – ID33740004ZJ DC1901A - ESCC 9000 chart F4 sg1-3 (also available, HCC4068BDG – ID33807006ZW DC1909A – ESCC 9000 chart F4 sg1-3) Flat pack: HCC4011BKT – ID3314000EYD DC1903A – ESCC 9000 chart F4 sg1-3 (also available M54HC00KT – ID33126D17YY DC1902A – ESCC 9000 chart F4 sg1-3)

Cover the validation of packages for both families as agreed by Qualification Board at its march 2001 meeting (minute 11.1 refers).

[9] Minor PID changes:

- Some products are now available in AMK 6"



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		Executive Memb	per: CNES	Date:	19/03/2020	190N	
Non compliance to ESCC requirements:							
No.:	Specification		Paragraph		Non compliance		
Additional tasks noncompliance:	required to achieve full	compliance for ESC	C qualification or rationale for acco	eptability of			
Executive Mana	ger Disposition						
Application App	roval: Yes 🗷	No 🗆				_	
Action / Remark	s:						

Date:

Digitally signed by Britta Schade Date: 2020.04.28 09:44:47 +02'00'

B. Schade: Head of ESA Product Assurance and Safety Department



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ANNEX 1: LIST OF TESTS DONE TO SUPPORT EXTENSION OF QUALIFICATION

Tests conducted in compliance with:

ESCC 9000 generic specification; Chart F4 (for ESCC/QPL parts);

Or PID-TFD (for ESCC/QML parts)

Tests vehicle identification/description:

AMK 5": M54HC00KT – ID33126D17YY DC 1902A M54HC74DT – ID33740004ZJ DC1901A AMK 6":

M54HC245KG - ID3382400401 DC 1906A M54HC165KG- ID3390600201 DC1908A

Dual in Line :

M54HC74DT - ID33740004ZJ DC1901A

Flat-pack:

HCC4011BKT ID 3314000EYD DC 1903A

Cover the validation of packages for both families as agreed by Qualification Board at its march 2001 meeting (minute 11.1 refers).

Detail Specification reference:

Chart F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection
Environmental/Mechanical Subgroup	Mechanical Shock	×	MIL-STD-883, Test Method 2002	Dual in Line : M54HC74DT – ID33740004ZJ DC1901A Flat-pack : HCC4011BKT ID3314000EYD DC 1903A	15	0	
	Vibration	×	MIL-STD-883, Test Method 2007		15	0	
	Constant Acceleration	×	MIL-STD-883, Test Method 2001		15	0	
	Seal (Fine and Gross Leak)	⊠	MIL-STD-883, Test Method 1014		15	0	
	Intermediate and End-Point Electrical Measurements	\boxtimes	Intermediate and End-Point Electrical Measurements in the Detail Specification		15	0	
	External Visual Inspection	\boxtimes	ESCC Basic Specification No. 20500		15	0	
	Thermal Shock	×	MIL-STD-883. Test Method 1011		15	0	
	Moisture Resistance	\boxtimes	MIL-STD-883, Test Method 1004		15	0	
	Seal (Fine and Gross Leak)	×	MIL-STD-883, Test Method 1014		15	0	
	Intermediate and End-Point Electrical Measurements	×	Intermediate and End-Point Electrical Measurements in the Detail Specification		15	0	
	External Visual Inspection	×	ESCC Basic Specification No. 20500		15	0	



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Chart F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection	
Endurance Subgroup	Operating Life	⊠	MIL-STD-883, Test Method 1005	AMK 5":	15	0		
	Intermediate and End-Point Electrical Measurements	×	Intermediate and End-Point Electrical Measurements in the Detail Specification	M54HC00KT – ID33126D17YY DC 1902A M54HC74DT – ID33740004ZJ	15	0	M54HC153D 1000h done and 2000h in progress	
	Seal (Fine and Gross Leak)	\boxtimes	MIL-STD-883, Test Method 1014	DC1901A	15	0		
	External Visual Inspection	×	ESCC Basic Specification No. 20500	AMK 6": M54HC245KG – ID3382400401 DC 1906A M54HC165KG- ID3390600201 DC1908A	15	0		
Assembly Capability Subgroup	Permanence of Marking		ESCC Basic Specification No. 24800	Dual in Line : M54HC74DT –			Not applicable	
	Terminal Strength	×	MIL-STD-883, Test Method 2004	ID33740004ZJ DC1901A	5	0		
	Internal Visual Inspection		ESCC Basic Specification No. 20400	Flat-pack :	5	0		
	Bond Strength	×	MIL-STD-883 Test Method 2011	HCC4011BKT ID3314000EYD DC 1903A	2	0		
	Die Shear or Substrate Attach Strength	×	MIL-STD-883 Test Method 2019 or 2027	DC 1903A	2	0		
Additional Tests								



Box 21

Box 22

Additional Comments.

APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL

Component title: 54HC and 54HCT Series

CNES 19/03/2020 Executive Member: Date:

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ı	NOTES ON THE COMPLETION OF THE APPLICATION FORM FOR ESCC QUALIFICATION EXTENSION APPROVAL
ENTRIES Form heading	shall indicate: - the title of the component as given in its detail specification or the name of the series, family; - the Executive Member; - the entering date; - the certificate number and its sequential suffix.
Box 1	shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.
Box 2; 3 and 4	As per QPL entry; otherwise, an explanation of the changes must be supplied.
Box 5	Will show the ESCC Generic and Detail specifications, including issue number and revision letter, current at the time the tests reported were performed. If the specifications are different from those current on the date of the application, see Box 6.
Box 6	Will show the deviations from the Generic and Detail Specifications listed in Box 5, in particular deviations from testing. In case of deviations this must be listed in Box 15. In case the referenced specification in Box 5 have currently a different issue and/or revision indicate also whether the test data deviates or not from such current documents.
Box 7	Must reference the report(s) supplied in support of the application.
Box 8	Should provide the details of procurement to the full ESCC System, documentation of all of which should already have been delivered to the ESCC Executive under the terms of the relevant Generic Specification. An appropriate table has been drawn in this box.
Box 9	If the PID evolved after the Original Qualification or after the last Extension of Qualification, adequate details of such evolution shall be provided together with the reasons for the changes. Major changes shall be clearly marked.
Box 10	Identify the current PID issue status, date and actual date of verification. The date of verification of the current PID should be arranged as close as possible to the required date of extension.
Box 11	This box can be completed only after a physical visit to the plant to confirm that no unexplained changes occurred and that the practices, procedures, material, etc. used in manufacturing the components are as described in the PID. This survey shall be carried out in accordance with the requirements of ESCC Basic Specification No. 20200 and its findings shall be recorded.
Box 12	Provide details of, or reference to, any Destructive Physical Analysis (DPA) and Failure Analysis reports as well as any Nonconformance(s) (NCCS) occurred during the qualification validity period, stating if established corrective action have produced satisfactory results.
Box 13	Enter only the name of the Executive Member (i.e., CNES, DLR, ESTEC, etc.) and the signature of the responsible Executive Coordinator.
Box 14	To be used when there is a need to expand any of the boxes from 1 through 12. Identify box affected and reference the Box 14 in the relevant Box. Box 14 can be broken into 14a, 14b, etc. if several boxes have to be expanded.
Box 15	Fill in Table as requested.
Box 16	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.
Box 17	All Executive Manager recommendations on the application itself, special conditions or restrictions, modifications of the QPL or QML entry, letters to the manufacturer, etc. shall be entered clearly in Box 19, signed by the representative for ESA, and dated.
Box 18	Fill in Table as requested.
Box 19	Confidential Details of PID changes including those of a confidential nature, shall be provided.
Box 20	State noncompliance with reference to specification(s) and paragraph(s). To simplify reference in Box 16 each nonconformance shall be sequentially numbered. If relevant state 'None'.

Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.